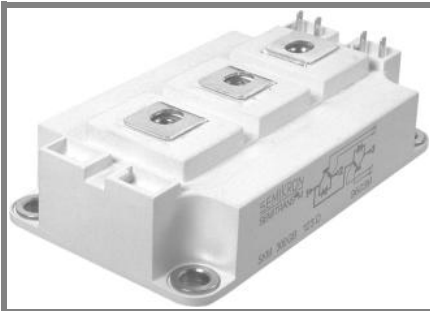


# SKM 150GB123D



**SEMITRANS® 3**

## IGBT Modules

**SKM 150GB123D**

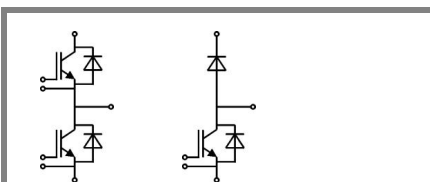
**SKM 150GAL123D**

### Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to  $6 \times I_{Cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (12 mm) and creepage distances (20 mm)

### Typical Applications

- AC inverter drives
- UPS



**GB**

**GAL**

Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$ , unless otherwise specified		
Symbol	Conditions	Values		Units
<b>IGBT</b>				
$V_{CES}$	$T_j = 25^\circ\text{C}$	1200		V
$I_C$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	150	A
		$T_{case} = 80^\circ\text{C}$	110	A
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$	200		A
$V_{GES}$		$\pm 20$		V
$t_{psc}$	$V_{CC} = 600\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125^\circ\text{C}$ $V_{CES} < 1200\text{ V}$	10		$\mu\text{s}$
<b>Inverse Diode</b>				
$I_F$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	150	A
		$T_{case} = 80^\circ\text{C}$	100	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$	200		A
$I_{FSM}$	$t_p = 10\text{ ms}; \text{sin.}$	$T_j = 150^\circ\text{C}$	1100	A
<b>Freewheeling Diode</b>				
$I_F$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	200	A
		$T_{case} = 80^\circ\text{C}$	135	A
$I_{FRM}$		300		A
$I_{FSM}$	$t_p = 10\text{ ms}; \text{sin.}$	$T_j = 150^\circ\text{C}$	1440	A
<b>Module</b>				
$I_{t(RMS)}$		500		A
$T_{vj}$		- 40 ... + 150		$^\circ\text{C}$
$T_{stg}$		-40 ... + 125		$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	2500		V

Characteristics		$T_c = 25^\circ\text{C}$ , unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
<b>IGBT</b>						
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 4\text{ mA}$	4,5	5,5	6,5	V	
$I_{CES}$	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}$	$T_j = 25^\circ\text{C}$	0,1	0,3	mA	
		$T_j = 125^\circ\text{C}$			mA	
$V_{CE0}$		$T_j = 25^\circ\text{C}$	1,4	1,6	V	
		$T_j = 125^\circ\text{C}$	1,6	1,8	V	
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	11	14	$\text{m}\Omega$	
		$T_j = 125^\circ\text{C}$	15	19	$\text{m}\Omega$	
$V_{CE(sat)}$	$I_{Cnom} = 100\text{ A}, V_{GE} = 15\text{ V}$		2,5	3	V	
$C_{ies}$	$V_{CE} = 25, V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	6,5		8,5	nF
$C_{oes}$			1		1,5	nF
$C_{res}$			0,5		0,6	nF
$Q_G$	$V_{GE} = -8\text{ V} - +20\text{ V}$	1000			nC	
$R_{Gint}$	$T_j = ^\circ\text{C}$	2,5			$\Omega$	
$t_{d(on)}$	$R_{Gon} = 6,8\ \Omega$	$V_{CC} = 600\text{ V}$ $I_{Cnom} = 100\text{ A}$	160	320	ns	
			80	160	ns	
$E_{on}$	$R_{Goff} = 6,8\ \Omega$	$T_j = 125^\circ\text{C}$ $V_{GE} = \pm 15\text{ V}$	13		mJ	
$t_{d(off)}$			400	520	ns	
$t_f$			70	100	ns	
$E_{off}$			11		mJ	
$R_{th(j-c)}$	per IGBT			0,15	K/W	

# SKM 150GB123D



**SEMITRANS® 3**

## IGBT Modules

**SKM 150GB123D**

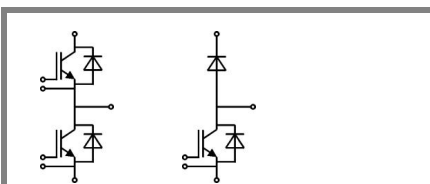
**SKM 150GAL123D**

### Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to  $6 \times I_{cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (12 mm) and creepage distances (20 mm)

### Typical Applications

- AC inverter drives
- UPS



**GB**

**GAL**

### Characteristics

Symbol	Conditions	min.	typ.	max.	Units
<b>Inverse Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 100 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$	2	2,5	V
		$T_j = 125 \text{ }^\circ\text{C}_{chiplev.}$	1,8		V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$	1,1	1,2	V
		$T_j = 125 \text{ }^\circ\text{C}$			V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$	9	13	mΩ
		$T_j = 125 \text{ }^\circ\text{C}$			mΩ
$I_{RRM}$	$I_{Fnom} = 100 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$	50		A
$Q_{rr}$	$di/dt = 1000 \text{ A}/\mu\text{s}$		5		μC
$E_{rr}$	$V_{GE} = 0 \text{ V}; V_{CC} = 600 \text{ V}$				mJ
$R_{th(j-c)D}$	per diode			0,3	K/W
<b>Freewheeling Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 150 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$	2	2,5	V
		$T_j = 125 \text{ }^\circ\text{C}_{chiplev.}$	1,8		V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$	1,1	1,2	V
		$T_j = 125 \text{ }^\circ\text{C}$			V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$	6	8,7	V
		$T_j = 125 \text{ }^\circ\text{C}$			V
$I_{RRM}$	$I_{Fnom} = 100 \text{ A}$	$T_j = 25 \text{ }^\circ\text{C}$	40		A
$Q_{rr}$			5		μC
$E_{rr}$	$V_{GE} = 0 \text{ V}; V_{CC} = 600 \text{ V}$				mJ
$R_{th(j-c)FD}$	per diode			0,25	K/W
<b>Module</b>					
$L_{CE}$			15	20	nH
$R_{CC'+EE'}$	res., terminal-chip	$T_{case} = 25 \text{ }^\circ\text{C}$	0,35		mΩ
		$T_{case} = 125 \text{ }^\circ\text{C}$	0,5		mΩ
$R_{th(c-s)}$	per module			0,038	K/W
$M_s$	to heat sink M6		3	5	Nm
$M_t$	to terminals M6		2,5	5	Nm
w				325	g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

# SKM 150GB123D



**SEMITRANS® 3**

## IGBT Modules

**SKM 150GB123D**

**SKM 150GAL123D**

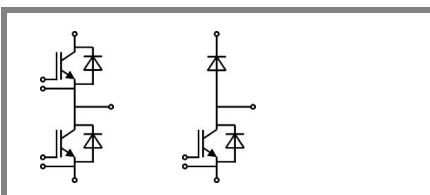
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### Typical Applications

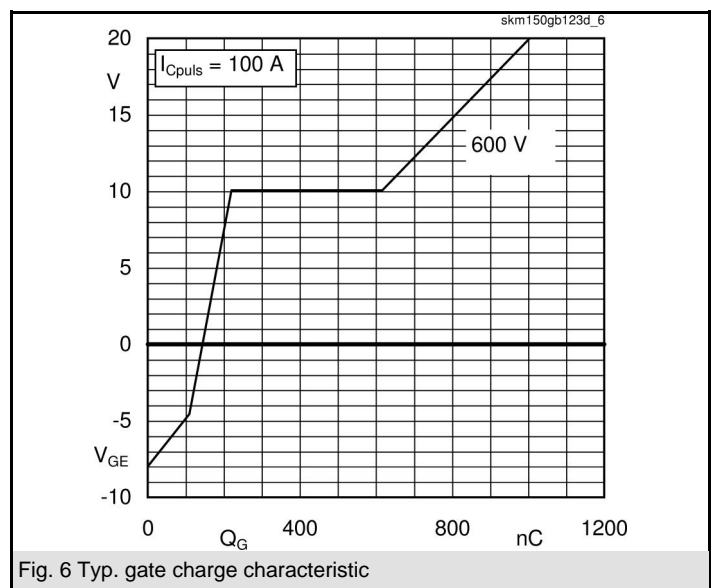
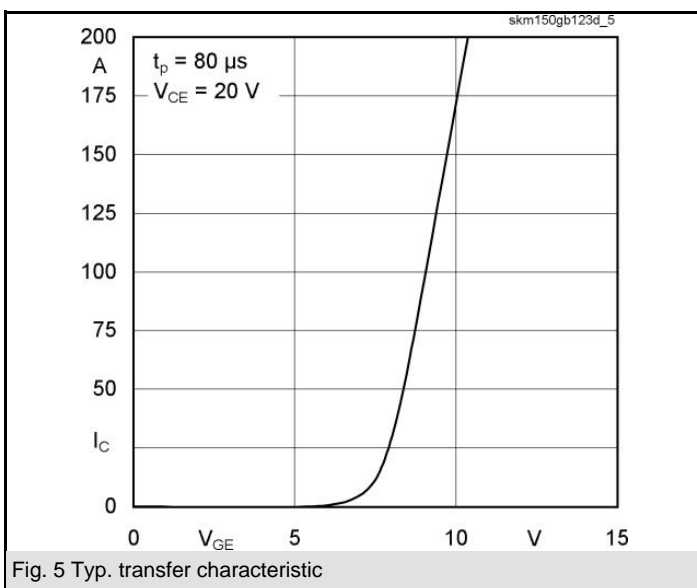
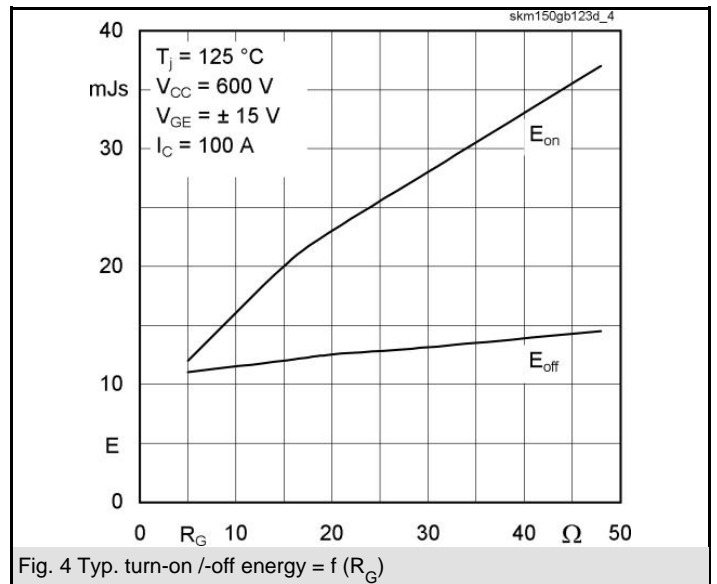
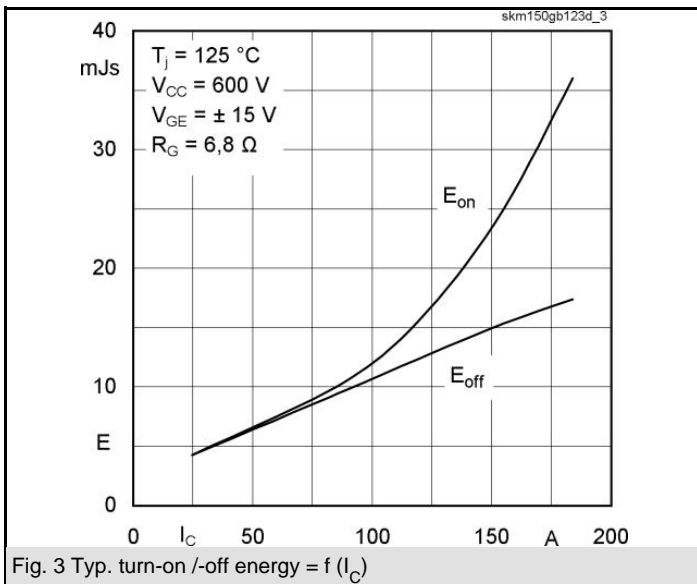
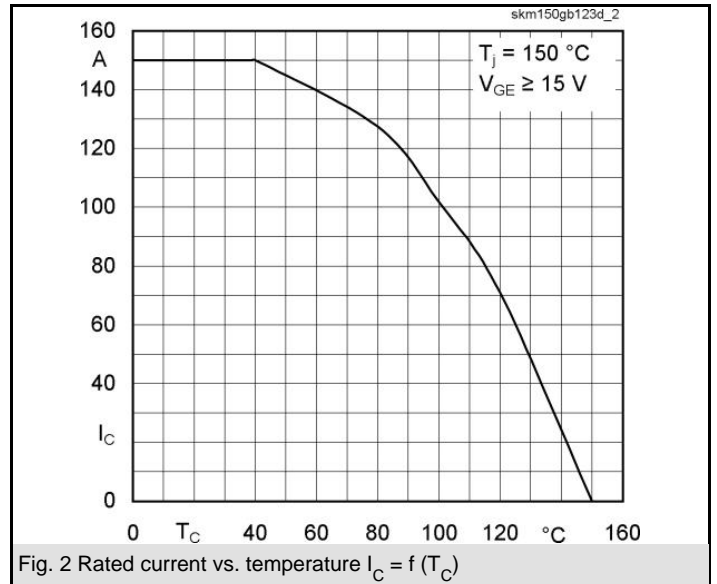
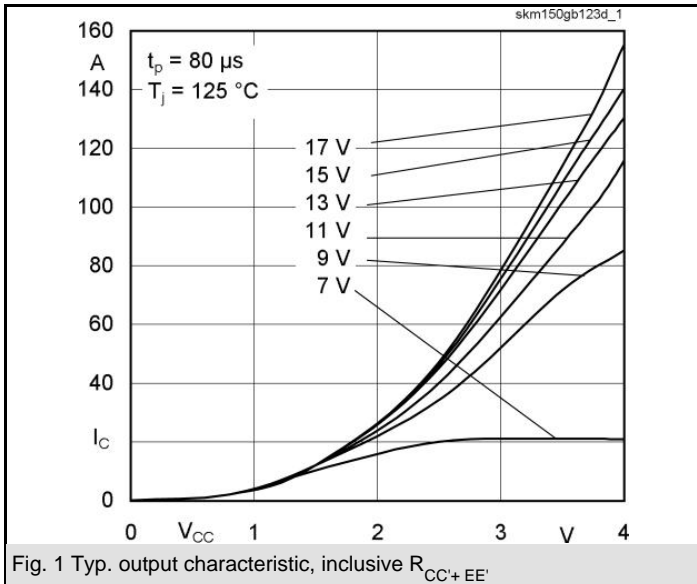
- AC inverter drives
- UPS

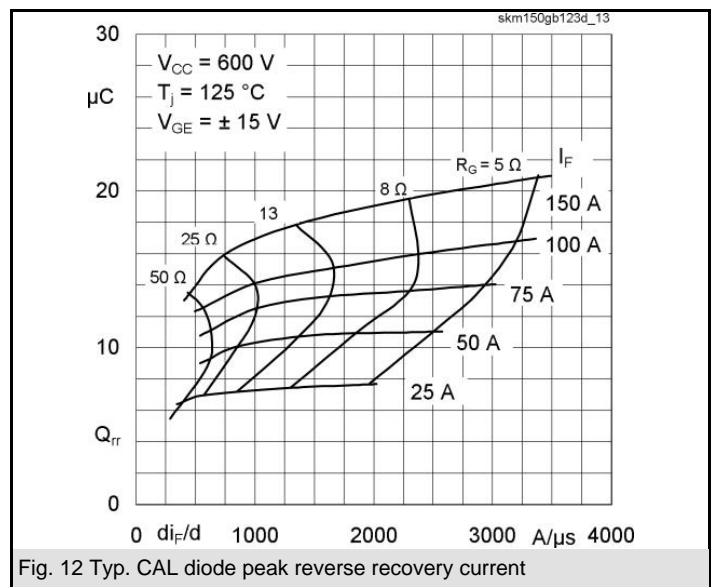
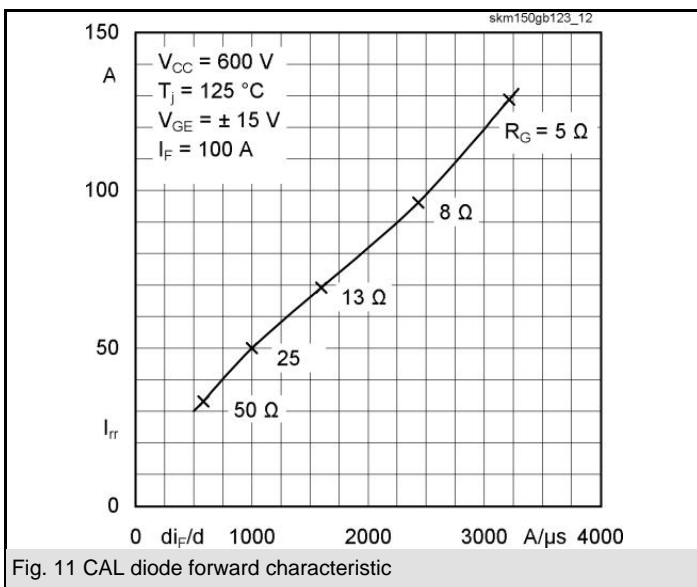
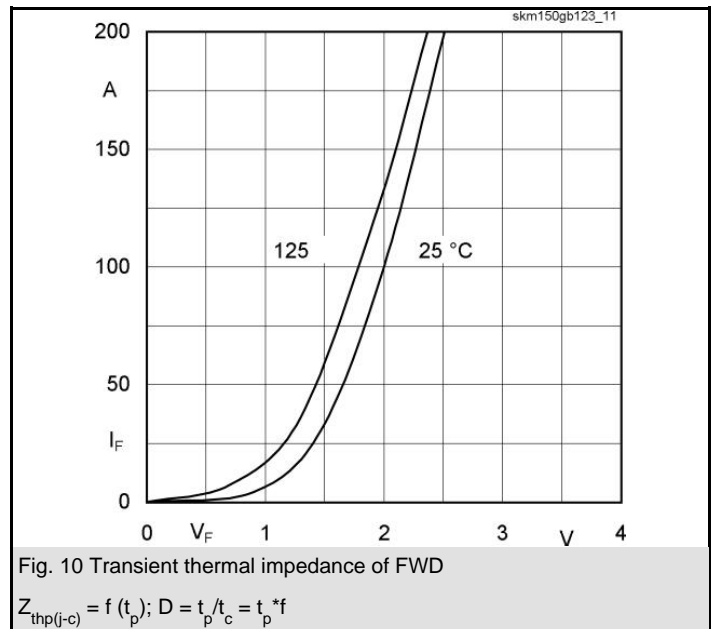
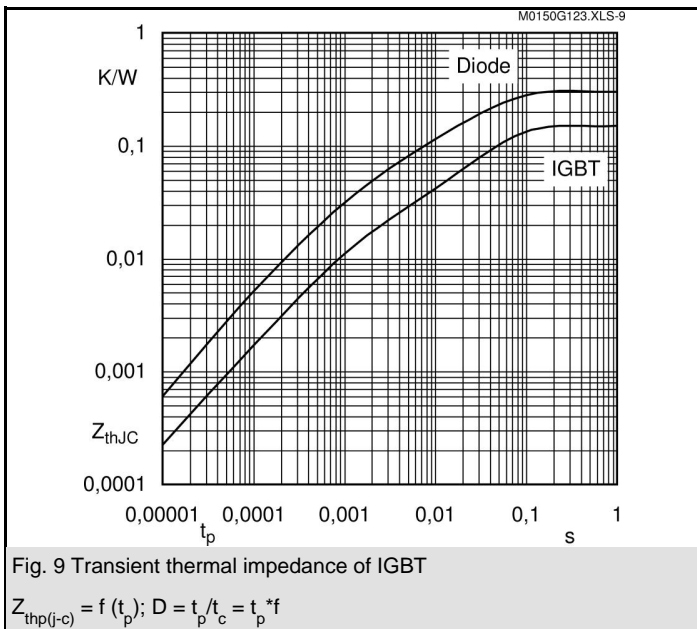
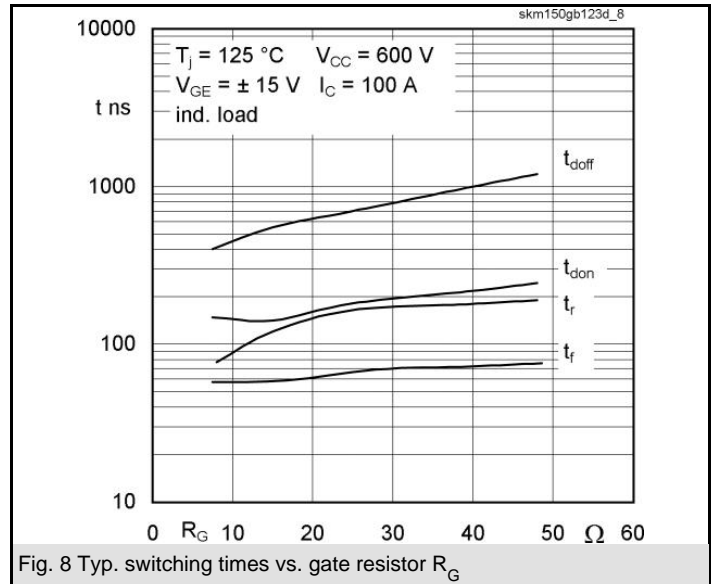
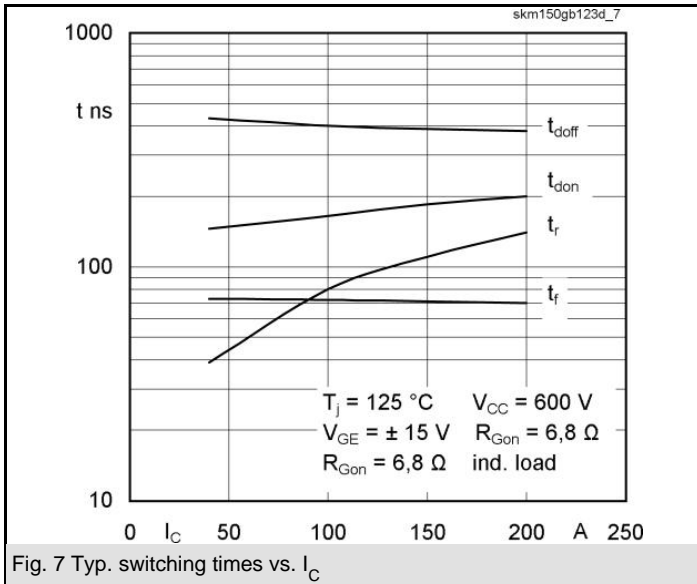
$Z_{th}$		Conditions	Values	Units
<b><math>Z_{th(j-c)I}</math></b>				
$R_{\theta j-c}$	$i = 1$		105	mk/W
$R_{\theta j-c}$	$i = 2$		35	mk/W
$R_{\theta j-c}$	$i = 3$		8	mk/W
$R_{\theta j-c}$	$i = 4$		2	mk/W
$\tau_{th j-c}$	$i = 1$		0,03	s
$\tau_{th j-c}$	$i = 2$		0,03	s
$\tau_{th j-c}$	$i = 3$		0,0014	s
$\tau_{th j-c}$	$i = 4$		0,0001	s
<b><math>Z_{th(j-c)D}</math></b>				
$R_{\theta j-cD}$	$i = 1$		210	mk/W
$R_{\theta j-cD}$	$i = 2$		70	mk/W
$R_{\theta j-cD}$	$i = 3$		16	mk/W
$R_{\theta j-cD}$	$i = 4$		4	mk/W
$\tau_{th j-cD}$	$i = 1$		0,0623	s
$\tau_{th j-cD}$	$i = 2$		0,0083	s
$\tau_{th j-cD}$	$i = 3$		0,003	s
$\tau_{th j-cD}$	$i = 4$		0,0002	s



**GB**

**GAL**





# SKM 150GB123D

UL Recognized

CASED56

File no. E63 532



Case D 56



GB

Case D 56



GAL

Case D 57 (→ D 56)